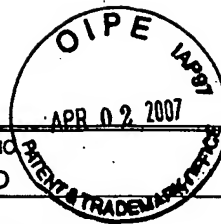




Form PTO 1400 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 246668US2RD		SERIAL NO. 10/736,830	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takashi KAWAKUBO			
				FILING DATE December 17, 2003		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
MB	AA	6,060,818	05/09/2000	R. C. RUBY, et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO						
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered		
MB					5-14-07		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
246668US2RDSERIAL NO.
10/736,830

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Takashi KAWAKUBOFILING DATE
December 17, 2003GROUP
2644

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>mb</i>	AA	US 6,242,842 B1	06/05/2001	Wolfgang PAHL, et al.			
	AB	US 6,449,828 B2	09/17/2002	Wolfgang PAHL, et al.			
	AC	US 6,914,367 B2	07/05/2005	Osamu FURUKAWA			
<i>mb</i>	AD	US 2004/0201305 A1	10/14/2004	Robert AIGNER, et al.			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>mb</i>	AO	61-218214	09/27/1986	Japan (with English abstract)		X
	AP	9-83029	03/28/1997	Japan (with English abstract)		X
	AQ	2002-314368	10/25/2002	Japan (with English abstract)		X
	AR	2002-16466	01/18/2002	Japan (with English abstract)		X
	AS	64-41309	02/13/1989	Japan (with English abstract)		X
	AT	11-502974	03/09/1999	Japan (corresponding to references US 6,242,842 B1 and US 6,449,828 B2)		X
	AU	WO 02/05424 A1	01/17/2002	WIPO (with English Abstract and corresponding to reference US 6,914,367 B2)		X
	AV	6-295181	10/21/1994	Japan (with English abstract)		X
<i>mb</i>	AW	WO 03/030358 A1	04/10/2003	WIPO (with English Abstract and corresponding to reference US 2004/0201305 A1)		X

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AX	
	AY	
	AZ	

Examiner

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Date Considered: 5-14-07

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